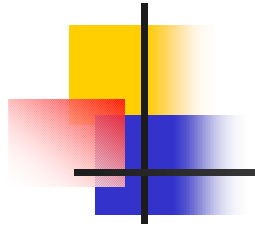




LQ search in $eejj$ channel (preliminary status report)

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Andrej Rosano (Trieste)



Introduction

- Some beyond the SM models assume additional symmetry between leptons and quarks
- LeptoQuarks – transition between leptons and quarks
 - Have both lepton and baryon numbers
 - λ - unknown coupling to leptons and quarks

LQ at the TeVatron

■ Production

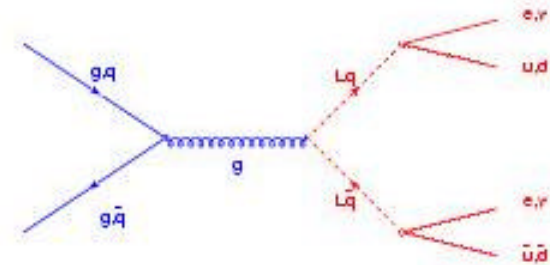
- $qg \rightarrow LQ + LQbar$
- $gg \rightarrow LQ + LQbar$
- $q\bar{q} \rightarrow LQ + Lqbar$

■ Decay

- $LQ \rightarrow l^+l^-qq, l^\pm nqq, nnqq$

■ Experimental signature:

- High pt isolated leptons (and/or MET) + jets

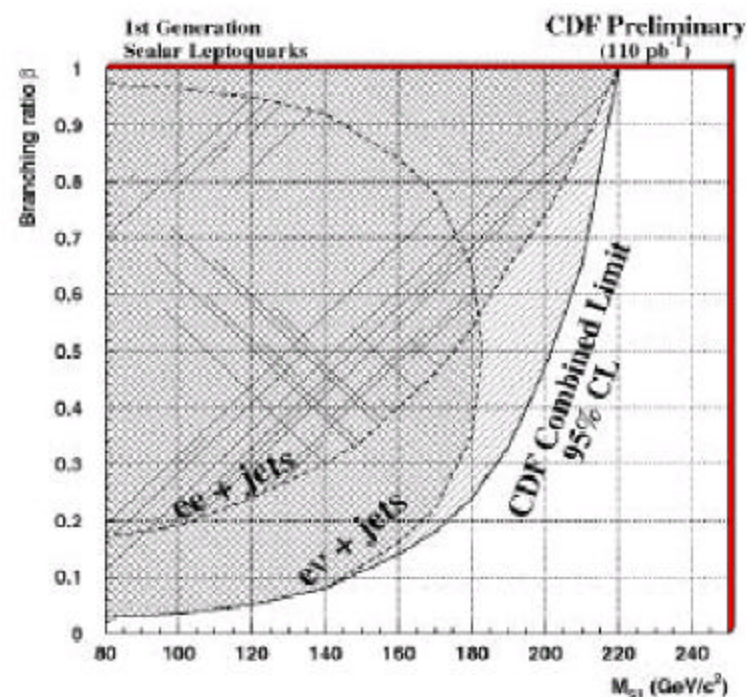


Tevatron Leptoquark Limits

- Limits depend on type of LQ (scalar/vector, generation), LQ-q-l couplings and $\beta = \text{BR}(\text{LQ} \rightarrow l^\pm q)$

1st generation LQ mass limits

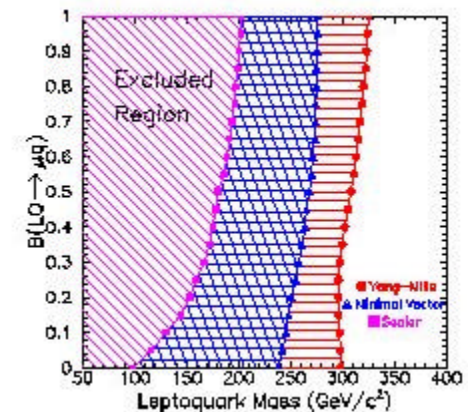
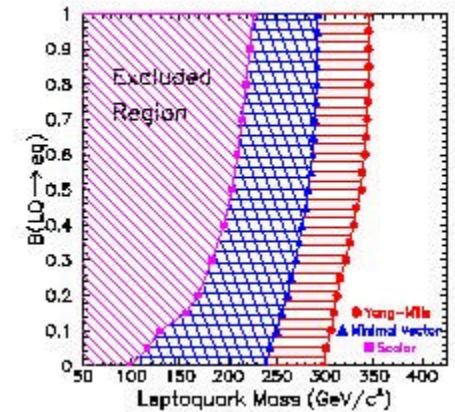
1 st Gen.	β	Scalar (GeV/c)	Vector Minimal Coupling (GeV/c)	Vector Yang-Mills Coupling (GeV/c)
DZero	1	225(242)	292	345
	0.5	204	282	337
	0	98	238	298
CDF	1	220(242)	280	330
	0.5	202	265	310

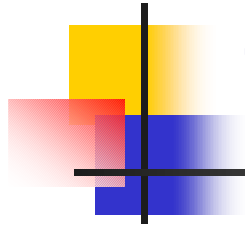


Tevatron Leptoquark Limits

2 nd Gen	β	Scalar (GeV/c)	Vector Minimal Coupling (GeV/c)	Vector Yang-Mills Coupling (GeV/c)
DZero	1	200	275	325
	0.5	180	260	310
	0	98	238	298
CDF	1	202	171	222
	0	123		

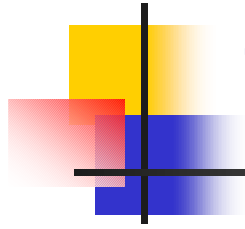
3 rd Gen	β	Scalar (GeV/c)	Vector Minimal Coupling (GeV/c)	Vector Yang-Mills Coupling (GeV/c)
DZero	0.5	98	238	209
	0			298
CDF	1	99	170	225
	0	148	199	250





This analysis

- Will start with eejj channel
 - High pt ele dataset used already for DY analysis
 - + Jets requirement
 - 2 isolated electrons
 - One tight (central)
 - One loose (central or plug)
 - At least 2 energetic jets
 - Will follow Federica Strumia's analysis
 - Not trying to change cuts now, trying to reproduce her numbers



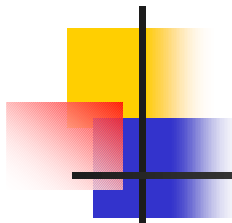
This analysis

- MC study
 - Signal
 - Ele id efficiency
 - Analysis cuts efficiency
 - Background
 - $t\bar{t}$ bar with W decay to \ln
 - DrellYan with radiative jets from ISR



Tools

- Signal generated and reprocessed with 4.8.2
 - 1000 events at masses from 200 to 320
- eN (4.8.2) used for ntuple analysis
 - <http://ncdf70.fnal.gov:8001/talks/eN/eN.html>



Electron ID

■ At least on central ele

- $E_t \geq 20 \text{ GeV}$ ($|\eta| < 1.5$)
- $\text{hadem} \leq 0.055$
- $E/p < 1.8$
- $\text{iso4e/emet} < 0.1$
- $|Dx| < 1.5$
- $|Dz| < 3.0$
- $\text{lsht} \leq 0.2$
- $|\chi^2_{2s}| < 10$
- $|\text{vtx}_{zv} - \text{el}_{zv}| < 5$
- $|\text{el}_{zv}| < 60$
- Conversion removal
- Fiducial > 0

CUT	Tight (Central)	Loose (Central / Plug)
Had/Em	< 0.05	< 0.1
E/p	< 1.8	$< 4.0 / \text{none}$
Isolation	< 0.1	< 0.1
$ \Delta x $	$\leq 1.5 \text{ cm}$	<i>none</i>
$ \Delta z $	$\leq 3.0 \text{ cm}$	<i>none</i>
L_{shr}	< 0.2	<i>none</i>
χ^2_{str}	< 10.0	<i>none</i>
$\chi^2_{3 \times 3}$	<i>none</i>	≤ 3.0
$ Z_v - Z_e $	$\leq 5.0 \text{ cm}$	<i>none</i>
$ Z_v $	$\leq 60.0 \text{ cm}$	<i>none</i>
Conversion	yes	yes
Fiducial	yes	<i>none</i>

Second Loose ele

- $E_t \geq 15 \text{ GeV}$
- Isolation
- $E/p < 4$



eN electron

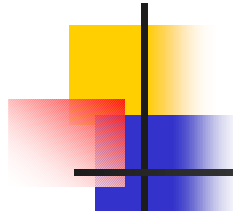
- In eN the information from cdfEmObject is replicated at 3 levels:
 - 1. EM cluster + EM object info + trkid and charge (not zero for electron)
 - 2. Cluster Seed + CES strip/wire + hadronic component + track info
 - 3. PES (the PES2d cluster, matched to the highest Pt track if it exists, is accepted if $DR \leq 0.25$ respect the extrapolated track. If no track, the PES 2d cluster is accepted if it is contained in any PEM tower associated with the EmCluster.)

Switched on
levels 1 and 2



eN electron variables used

- Emet [nele] emEt() cluster e.m. Et in GeV
- tote [nele] totalEnergy() total (had+em) cluster Energy
- totet [nele] totalEt() total (had+em) cluster Et using default Z vertex
- hadem [nele] hadEm() cluster E(had)/E(em) using all towers in the cluster.
- iso4e [nele] totalIsolationEt4() cluster had + em excess Et(GeV) in DR=0.4
 - Isolation = iso4e/emet
- lshr [nele] lshrTrack or lshrUnbiased if no track (old lshr(3)) CEM only!
- trkDx [nele] xdiff() matching difference between x(trk at CES) and x(CES)
- trkDz [nele] zdiff() matching difference between z(trk at CES) and z(CES)
- fiducial [nele] how fiducial is this electron following fidEle()
- chi2s [nele] CES chi2 strips corrected with E(em) of the CEM corrected object



Federica's analysis

$N_{\text{passed}}/N_{\text{total}}$

$M_{S1}(\text{GeV}/c^2)$	$\varepsilon_e''^{e\nu jj''}$	$M_{S1}(\text{GeV}/c^2)$	$\varepsilon_{ee}''^{eejj''}$
140	$(72.2 \pm 2.2)\%$	100	$(65.9 \pm 1.9)\%$
150	$(72.0 \pm 2.1)\%$	120	$(65.2 \pm 1.8)\%$
160	$(72.0 \pm 2.1)\%$	140	$(63.7 \pm 1.7)\%$
170	$(70.9 \pm 2.1)\%$	160	$(60.3 \pm 1.6)\%$
180	$(69.7 \pm 2.0)\%$	180	$(62.9 \pm 1.7)\%$
190	$(70.1 \pm 2.1)\%$	200	$(60.8 \pm 1.6)\%$
200	$(67.7 \pm 2.0)\%$	220	$(60.3 \pm 1.6)\%$
210	$(69.7 \pm 2.0)\%$	240	$(58.5 \pm 1.5)\%$


Table 4.2: Electron-identification efficiencies evaluated on Monte Carlo leptoquark events for the two analyses in the scalar case.

N_{total} : evts with 2 central ele with 40-15, matching the generated ele

N_{passed} : evts with one ele passing the tight and one ele passing the loose id cuts

$M_{S1}(\text{GeV}/c^2)$	180	200	220	240
$E_{T_s} > 40, 15 \text{ GeV}$	$(82.9 \pm 1.6)\%$	$(86.0 \pm 1.6)\%$	$(87.8 \pm 1.6)\%$	$(88.7 \pm 1.7)\%$
$\geq 2 \text{ jets}$	$(65.3 \pm 1.3)\%$	$(66.4 \pm 1.3)\%$	$(68.2 \pm 1.4)\%$	$(68.3 \pm 1.4)\%$
$M_{ee} \text{ cut}$	$(57.0 \pm 1.2)\%$	$(58.6 \pm 1.2)\%$	$(61.6 \pm 1.3)\%$	$(62.7 \pm 1.3)\%$
$\sum E_{T_s} > 85 \text{ GeV}$	$(51.5 \pm 1.1)\%$	$(54.5 \pm 1.2)\%$	$(57.8 \pm 1.2)\%$	$(59.8 \pm 1.3)\%$
$\sqrt{\sum E_{T_s}^2} > 200 \text{ GeV}$	$(46.9 \pm 1.1)\%$	$(52.0 \pm 1.1)\%$	$(56.3 \pm 1.2)\%$	$(58.5 \pm 1.2)\%$
$\varepsilon_{\text{ID}}^{\text{el}}$	$(29.6 \pm 0.8)\%$	$(31.8 \pm 0.8)\%$	$(34.6 \pm 0.9)\%$	$(34.2 \pm 0.9)\%$

Table 5.8: The efficiency of each kinematical cut applied in the selection, and the total efficiency after the electron-ID cuts for different values of M_{S1} . The errors on the efficiencies are only statistical.



Ele id $E_{\text{passed}} / E_{\text{tot}}$ (#evts with at least 2 ele, 40, 15)

$m_{LQ} = 200$	$m_{LQ} = 220$	$m_{LQ} = 240$	$m_{LQ} = 260$
56.1% (60.8 ± 1.6)	55.7% (60.3 ± 1.6)	55.7% (58.5 ± 1.5)	53.4%
$m_{LQ} = 280$	$m_{LQ} = 300$	$m_{LQ} = 320$	$m_{LQ} = 340$
53.6%	53.5%	54.6%	



Analysis cuts

M_{S1}	200	220	240	260	280
$E_{te} \geq 40, 15 \text{ GeV}$	71.0%	71.8%	72.5%	75.9%	73.6%
$\geq 2 \text{ jets}$	66.8%	66.5%	68.5%	71.1%	68.9%
$M_{ee} \text{ cut}$	56.5%	54.6%	58.1%	59.9%	59.2%
$\Sigma E_{T's} \geq 85 \text{ GeV}$	49.1%	49.8%	54.0%	56.9%	56.1%
$\sqrt{\Sigma E_{T's}^2} \geq 200 \text{ GeV}$	46.4%	48.2%	53.4%	56.4%	55.7%
el_{ID}	26.03%	26.84%	29.74%	30.1%	29.8%

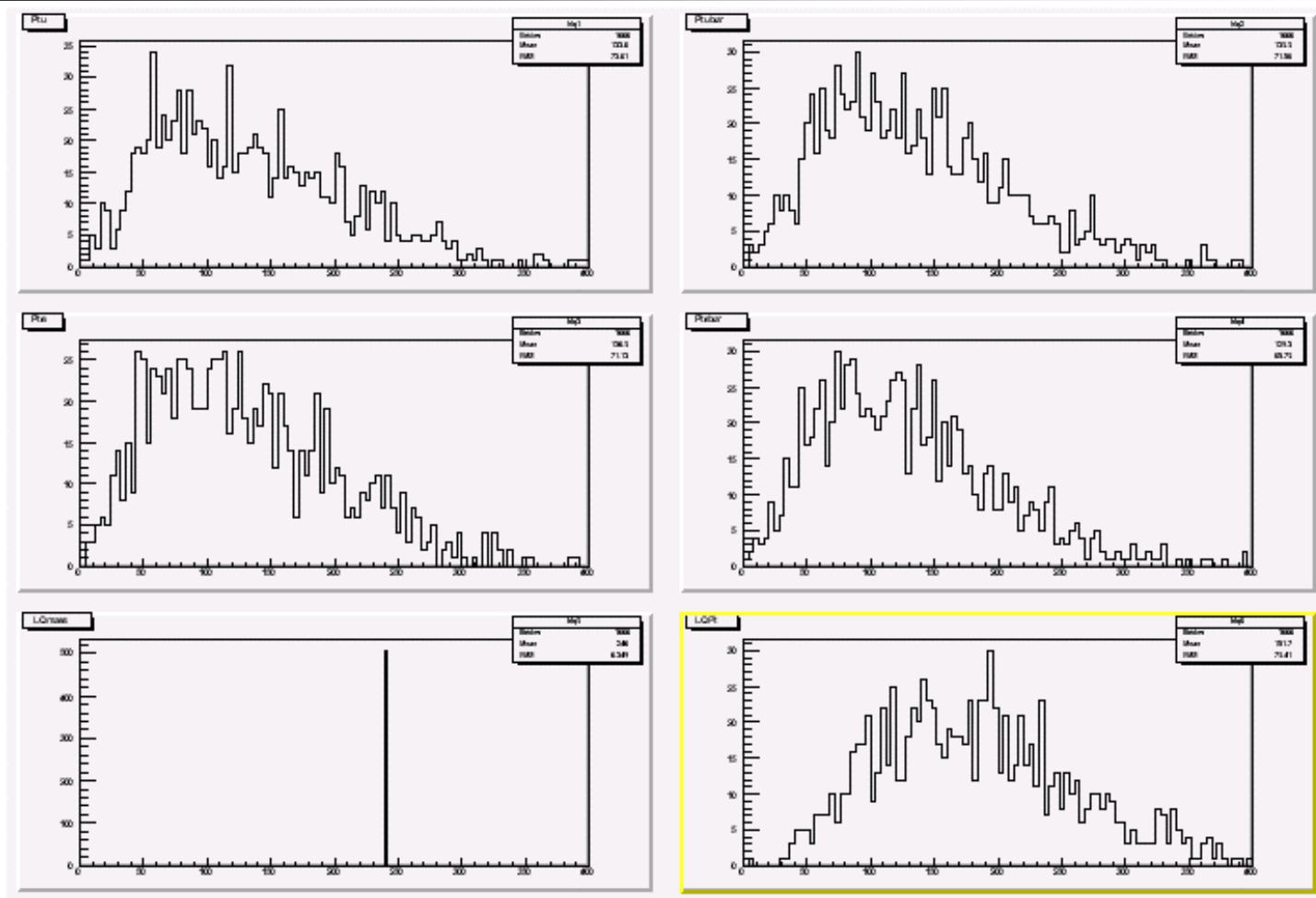


Ele id efficiency

- From data, the dielectron id efficiency were done by combining the individual efficiencies for tight-loose fiducial, tight-loose non fiducial and tight-plug where A,B,C are the proportions evaluated on MC samples of LQ for different masses, in which are present these 3 kinds of categories on the events.

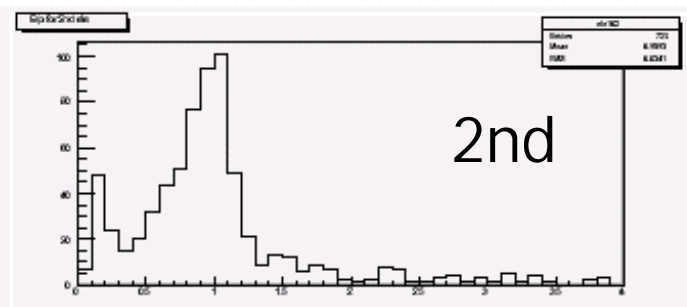
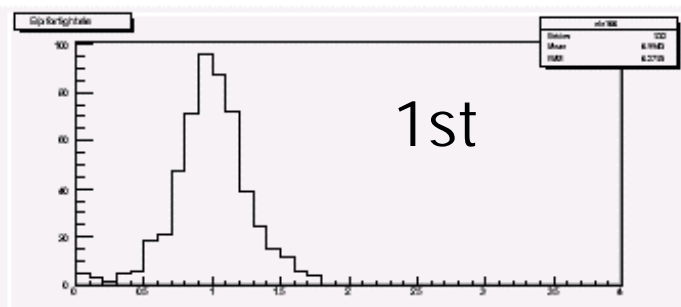
$$\epsilon_{ee} = A \times \epsilon_{tlf} + B \times \epsilon_{tlnf} + C \times \epsilon_{tlp}$$

HEPG ($LQ_m = 240$)

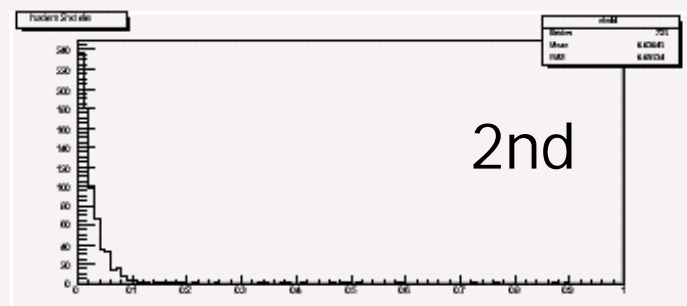
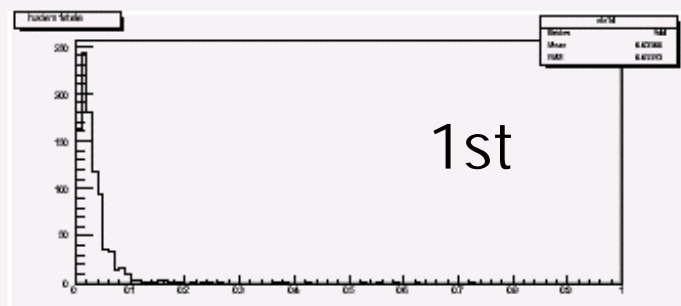


Electrons (LQ_m = 240)

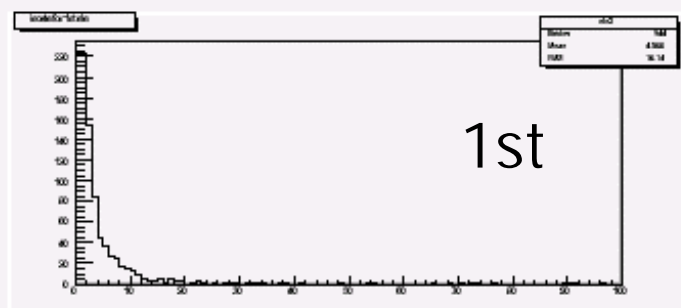
E/p



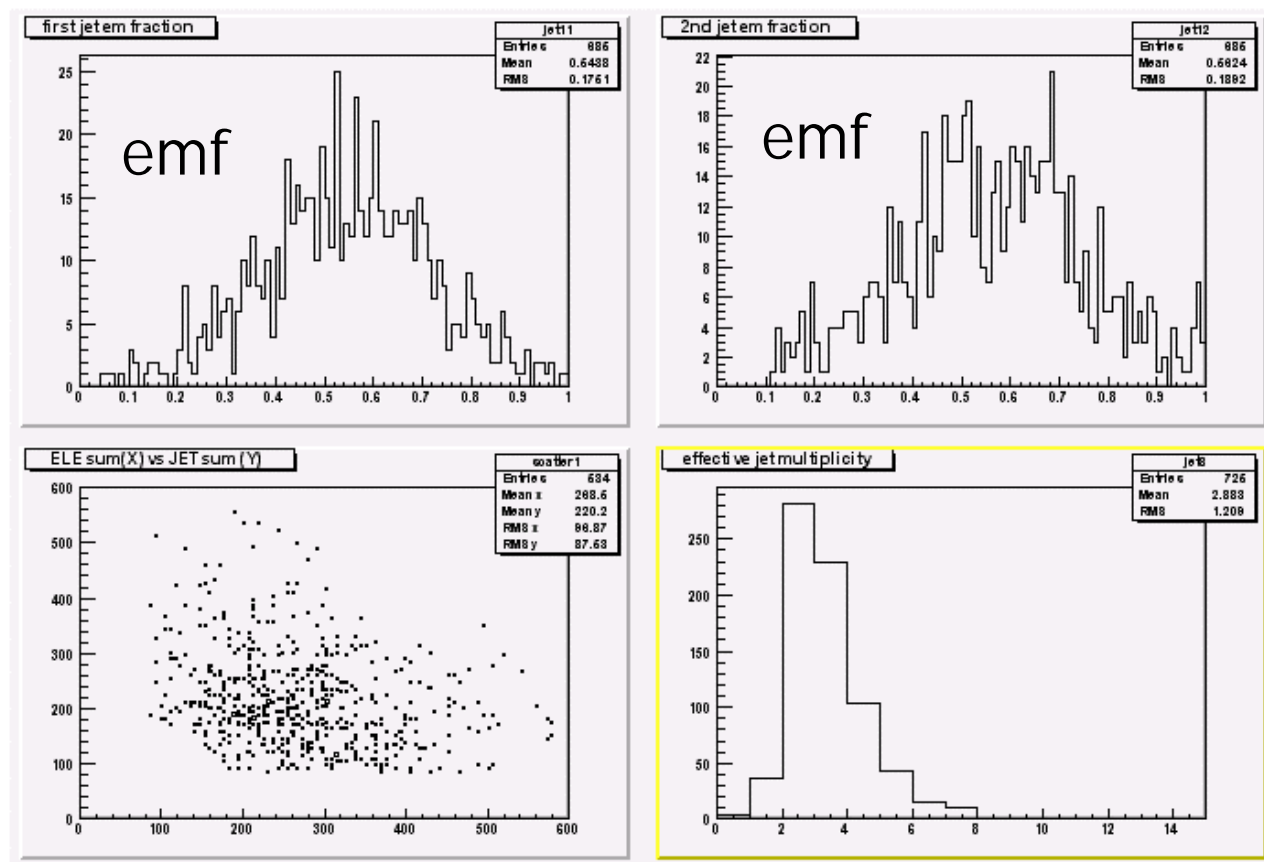
Had/em



iso4e



jets (LQ_m = 240)



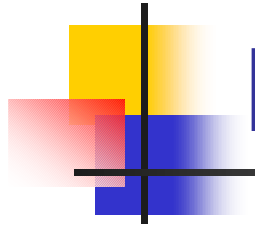


First look at bckg

- DY + jet

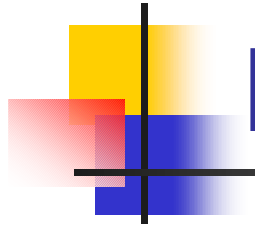
- Generated 5000 evts

- evt with 2 ele - 40 15 = 1407
 - evt with 2 ele - 40 15 and ≥ 2 jets = 721
 - evt with 2 ele - 40 15 and ≥ 2 jets = and M_{ee} cut = 699
 - evt with 2 ele - 40 15 and ≥ 2 jets = and M_{ee} cut and 2jet_85 = 24
 - evt with 2 ele - 40 15 and ≥ 2 jets = and M_{ee} cut and 2jet_85 and sumet cut = 3



First look at bckg

- Top, 500 evts
 - evt with 2 ele - 40 15 = 201
 - evt with 2 ele - 40 15 and ≥ 2 jets = 174
 - evt with 2 ele - 40 15 and ≥ 2 jets = and M_{ee} cut = 131
 - evt with 2 ele - 40 15 and ≥ 2 jets = and M_{ee} cut and 2jet_85 = 42
 - evt with 2 ele - 40 15 and ≥ 2 jets = and M_{ee} cut and 2jet_85 and sumet cut = 16



Plans

- Reprocess high et ele dataset with 4.8.4
 - Electron_central_18 & Electron_70
- Add jet selection
 - Jet corrections
- Check ele id with W mass analysis cuts
- Background studies
-
- limit